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L2	2	("6519607").PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	OFF	2005/01/28 15:36
L3	2	("6373047").PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	OFF	2005/01/28 15:36
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